

Notice of References Cited	Application/Control No. 10/081,234		Applicant(s)/Patent Under Reexamination TOTSUKA ET AL.	
	Examiner Quan-Zhen Wang		Art Unit 2613	Page 1 of 1

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NON-PATENT DOCUMENTS

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	U	N. Mukherjee et al. "Built-in self-test: a complete test solution for telecommunication systems"; IEEE Communications Magazine, June 1999, pages 72-78
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.